

CSD25501F3 –20V P-Channel FemtoFET™ MOSFET

1 Features

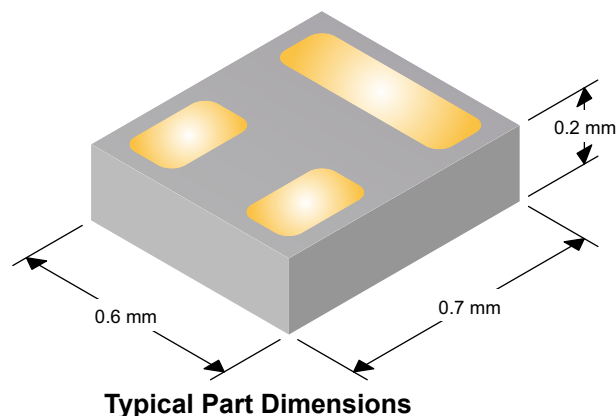
- Low on-resistance
- Ultra-low Q_g and Q_{gd}
- Ultra-small footprint
 - 0.7mm × 0.6mm
- Low profile
 - 0.22mm max height
- Integrated ESD protection diode
- Lead and halogen free
- RoHS compliant

2 Applications

- Optimized for load switch applications
- Battery applications
- Handheld and mobile applications

3 Description

This –20V, 64mΩ, P-Channel FemtoFET™ MOSFET is designed and optimized to minimize the footprint in many handheld and mobile applications. This technology is capable of replacing standard small signal MOSFETs while providing a substantial reduction in footprint size. The integrated 10kΩ clamp resistor (R_C) allows the gate voltage (V_{GS}) to be operated above the maximum internal gate oxide value of –6V, depending on duty cycle. The gate leakage (I_{GSS}) through the diode increases as V_{GS} is increased above –6V.



Product Summary

$T_A = 25^\circ\text{C}$		TYPICAL VALUE	UNIT
V_{DS}	Drain-to-Source Voltage	–20	V
Q_g	Gate Charge Total (–4.5V)	1.02	nC
Q_{gd}	Gate Charge Gate-to-Drain	0.09	nC
$R_{DS(on)}$	Drain-to-Source On-Resistance	$V_{GS} = -1.8\text{V}$	120
		$V_{GS} = -2.5\text{V}$	86
		$V_{GS} = -4.5\text{V}$	64
$V_{GS(th)}$	Threshold Voltage	–0.75	V

Device Information

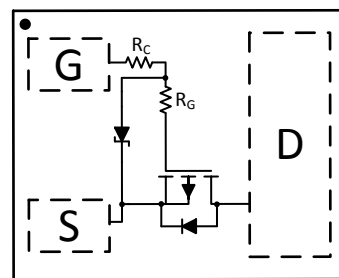
DEVICE ⁽¹⁾	QTY	MEDIA	PACKAGE	SHIP
CSD25501F3	3000	7 Inch Reel	Femto	Tape and Reel
CSD25501F3T	250		0.73mm × 0.64mm Land Grid Array (LGA)	

- (1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

$T_A = 25^\circ\text{C}$ (unless otherwise stated)		VALUE	UNIT
V_{DS}	Drain-to-Source Voltage	–20	V
V_{GS}	Gate-to-Source Voltage	–20	V
I_D	Continuous Drain Current ⁽¹⁾	–3.6	A
I_{DM}	Pulsed Drain Current ^{(1) (2)}	–13.6	A
P_D	Power Dissipation ⁽¹⁾	500	mW
$V_{(ESD)}$	Human Body Model (HBM)	4000	V
	Charged Device Model (CDM)	2000	
T_J, T_{stg}	Operating Junction, Storage Temperature	–55 to 150	$^\circ\text{C}$

- (1) Typical $R_{\theta JA} = 255^\circ\text{C/W}$ mounted on FR4 material with minimum Cu mounting area.
 (2) Pulse duration $\leq 100\mu\text{s}$, duty cycle $\leq 1\%$.



Top View



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4 Specifications

4.1 Electrical Characteristics

$T_A = 25^\circ\text{C}$ (unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC CHARACTERISTICS						
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0V, I _{DS} = -250μA	-20			V
I _{DSS}	Drain-to-source leakage current	V _{GS} = 0V, V _{DS} = -16V			-50	nA
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0V, V _{GS} = -6V			-50	nA
		V _{DS} = 0V, V _{GS} = -16V			-1	mA
V _{GS(th)}	Gate-to-source threshold voltage	V _{DS} = V _{GS} , I _{DS} = -250μA	-0.45	-0.75	-1.05	V
R _{DS(on)}	Drain-to-source on-resistance	V _{GS} = -1.8V, I _{DS} = -0.1A	120		260	mΩ
		V _{GS} = -2.5V, I _{DS} = -0.4A	86		125	
		V _{GS} = -4.5V, I _{DS} = -0.4A	64		76	
g _{fs}	Transconductance	V _{DS} = -2V, I _{DS} = -0.4A	3.4			S
DYNAMIC CHARACTERISTICS						
C _{iss}	Input capacitance	V _{GS} = 0V, V _{DS} = -10V, f = 100kHz	295		385	pF
C _{oss}	Output capacitance		70		91	pF
C _{rss}	Reverse transfer capacitance		4.1		5.3	pF
R _G	Series gate resistance		33			Ω
R _C	Series clamp resistance		10,000			Ω
Q _g	Gate charge total (-4.5 V)	V _{DS} = -10V, I _{DS} = -0.4A	1.02		1.33	nC
Q _{gd}	Gate charge gate-to-drain		0.09			nC
Q _{gs}	Gate charge gate-to-source		0.45			nC
Q _{g(th)}	Gate charge at V _{th}		0.36			nC
Q _{oss}	Output charge	V _{DS} = -10V, V _{GS} = 0V	1.8			nC
t _{d(on)}	Turnon delay time	V _{DS} = -10V, V _{GS} = -4.5V, I _{DS} = -0.4A, R _G = 0Ω	474			ns
t _r	Rise time		428			ns
t _{d(off)}	Turnoff delay time		1154			ns
t _f	Fall time		945			ns
DIODE CHARACTERISTICS						
V _{SD}	Diode forward voltage	I _{SD} = -0.4A, V _{GS} = 0V	-0.73		-0.95	V
Q _{rr}	Reverse recovery charge	V _{DS} = -10V, I _F = -0.4A, di/dt = 200A/μs	3.0			nC
t _{rr}	Reverse recovery time		7.4			ns

4.2 Thermal Information

$T_A = 25^\circ\text{C}$ (unless otherwise stated)

THERMAL METRIC		TYPICAL VALUES	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽¹⁾	90	$^\circ\text{C}/\text{W}$
	Junction-to-ambient thermal resistance ⁽²⁾	255	$^\circ\text{C}/\text{W}$

(1) Device mounted on FR4 material with 1in² (6.45cm²), 2oz (0.071mm) thick Cu.

(2) Device mounted on FR4 material with minimum Cu mounting area.

4.3 Typical MOSFET Characteristics

$T_A = 25^\circ\text{C}$ (unless otherwise stated)

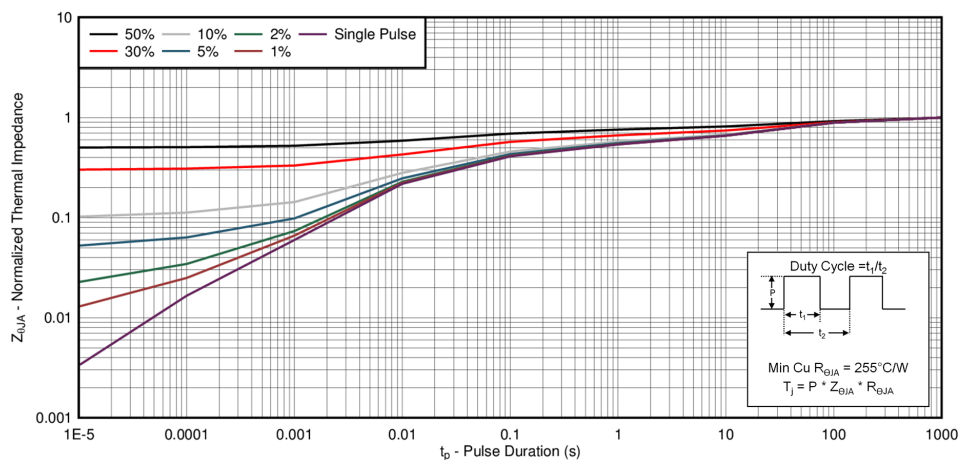


Figure 4-1. Transient Thermal Impedance

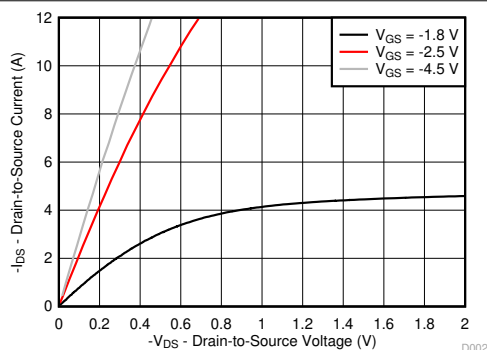


Figure 4-2. Saturation Characteristics

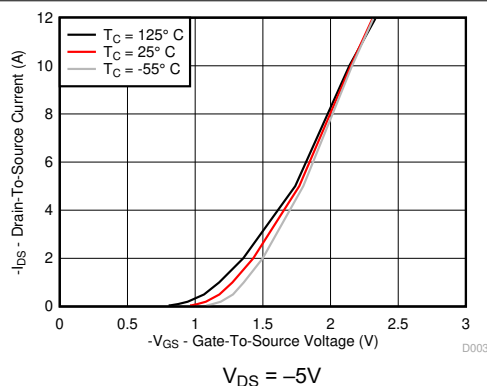


Figure 4-3. Transfer Characteristics

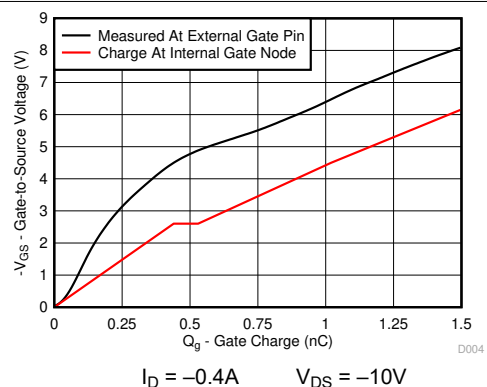


Figure 4-4. Gate Charge

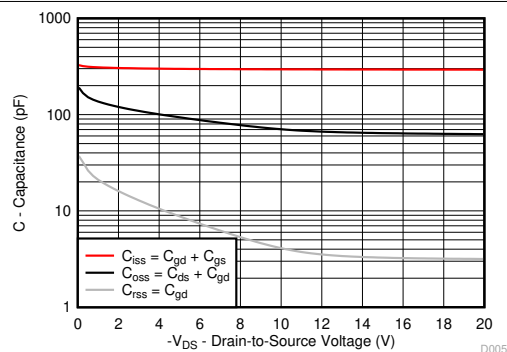


Figure 4-5. Capacitance

4.3 Typical MOSFET Characteristics (continued)

$T_A = 25^\circ\text{C}$ (unless otherwise stated)

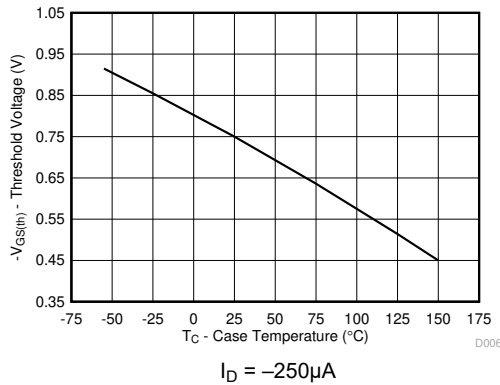


Figure 4-6. Threshold Voltage vs Temperature

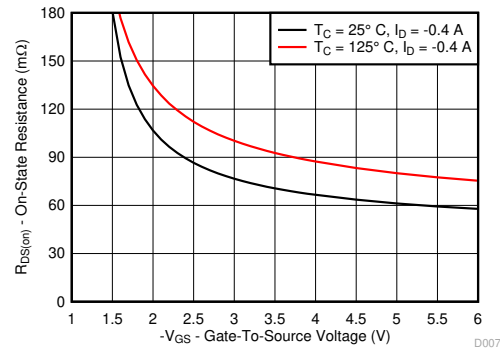


Figure 4-7. On-State Resistance vs Gate-to-Source Voltage

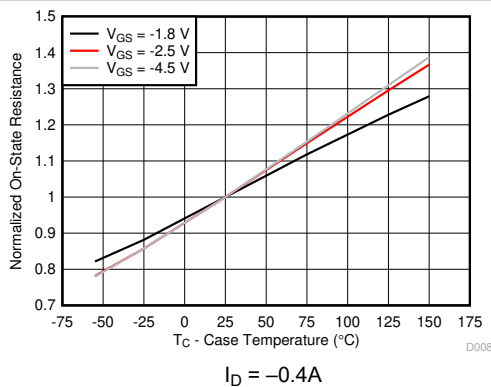


Figure 4-8. Normalized On-State Resistance vs Temperature

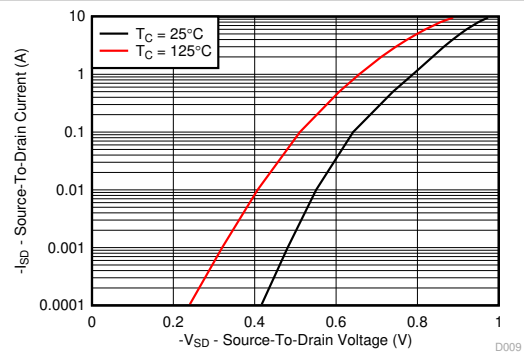


Figure 4-9. Typical Diode Forward Voltage

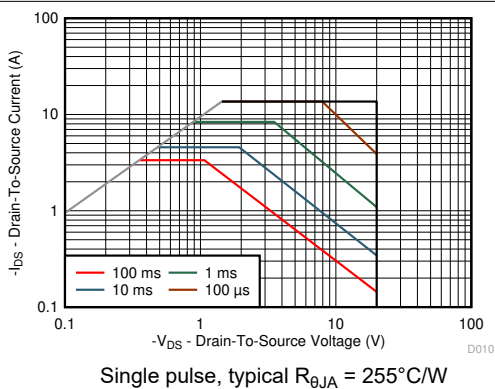


Figure 4-10. Maximum Safe Operating Area

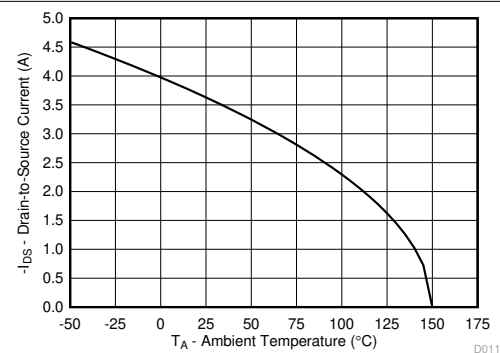


Figure 4-11. Maximum Drain Current vs Temperature

5 Device and Documentation Support

5.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](https://www.ti.com). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

5.2 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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5.3 Trademarks

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5.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

5.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

6 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision B (October 2021) to Revision C (June 2024)	Page
• Updated the numbering format for tables, figures, and cross-references throughout the document.....	1

7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Table 7-1. Pin Configuration

POSITION	DESIGNATION
Pin 1	Gate
Pin 2	Source
Pin 3	Drain

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD25501F3	ACTIVE	PICOSTAR	YJN	3	3000	RoHS & Green	NIAU	Level-1-260C-UNLIM	-55 to 150	V	Samples
CSD25501F3T	ACTIVE	PICOSTAR	YJN	3	250	RoHS & Green	NIAU	Level-1-260C-UNLIM	-55 to 150	V	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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